

FU224A-VB Datasheet

Power MOSFET

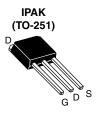
| PRODUCT SUMMARY | | | | | |
|----------------------------|----------------------------|--|--|--|--|
| V _{DS} (V) | 250 | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V 1.1 | | | | |
| Q _g (Max.) (nC) | 14 | | | | |
| Q _{gs} (nC) | 2.7 | | | | |
| Q _{gd} (nC) | 7.8 | | | | |
| Configuration | Single | | | | |

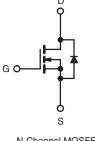
FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- · Fast Switching
- · Ease of Paralleling



COMPLIANT HALOGEN FREE Available





N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C : | = 25 °C, unl | less otherwis | se noted) | | | |
|---|-------------------------|-------------------------|-----------------------------------|---------------|-------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 250 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | V | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | I _D - | 3.8 | | |
| | V _{GS} at 10 V | T _C = 100 °C | | 2.4 | A | |
| Pulsed Drain Current ^a | | | I _{DM} | 15 | | |
| Linear Derating Factor | | | | 0.33 | W//8C | |
| Linear Derating Factor (PCB Mount) ^e | | | | 0.020 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 130 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 3.8 | A | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 4.2 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | D | 42 | 14/ | |
| Maximum Power Dissipation (PCB Mount) ^e | T _A = 25 °C | | P _D 2.5 | | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 4.8 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | °C | |
| Soldering Recommendations (Peak Temperature) ^d | for 10 s | | | 260 | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$; starting $T_J = 25 \text{ °C}$, L = 14 mH, $R_g = 25 \Omega$, $I_{AS} = 3.8 \text{ A}$ (see fig. 12). c. $I_{SD} \le 3.8 \text{ A}$, dl/dt $\le 90 \text{ A/}\mu$ s, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material) .



| THERMAL RESISTANCE RATINGS | | | | | | |
|---|-------------------|------|------|------|--|--|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT | | |
| Maximum Junction-to-Ambient (PCB Mount) ^a | R _{thJA} | - | 50 | | | |
| Maximum Junction-to-Ambient | R _{thJA} | - | 110 | °C/W | | |
| Maximum Junction-to-Case | R _{thJC} | - | 3.0 | | | |

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| PARAMETER | SYMBOL | TES | T CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|---|---|---|------------|-----------|----------------------|------------------|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 V, I_D = 250 \mu A$ | | 250 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference | Reference to 25 °C, $I_D = 1 \text{ mA}$ | | 0.36 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μΑ | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | | $V_{GS} = \pm 20 V$ | | - | ± 100 | nA |
| | | V _{DS} = 250 V, V _{GS} = 0 V | | - | - | 25 | μA |
| Zero Gate Voltage Drain Current | b Gate Voltage Drain Current I_{DSS} $V_{DS} = 200 V, V_{GS} = 0 V, T_J = 125 °C$ | | /, V _{GS} = 0 V, T _J = 125 °C | - | - | 250 | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 2.3 A ^b | - | 1.1 | - | Ω |
| Forward Transconductance | g _{fs} | V _{DS} = | V _{DS} = 50 V, I _D = 2.3 A ^b | | - | - | S |
| Dynamic | | | | | • | • | |
| Input Capacitance | C _{iss} | | V _{GS} = 0 V, | | 260 | - | |
| Output Capacitance | Coss | | $V_{DS} = 25 V$, | - | 77 | - | pF |
| Reverse Transfer Capacitance | C _{rss} | f = 1. | f = 1.0 MHz, see fig. 5 ^c | | 15 | - | |
| Total Gate Charge | Qg | | | - | - | 14 | |
| Gate-Source Charge | Q_gs | $V_{GS} = 10 V$ | $V_{GS} = 10 \text{ V} \qquad \begin{array}{c} I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b, c}} \end{array}$ | | - | 2.7 | nC |
| Gate-Drain Charge | Q _{gd} | | | | - | 7.8 | |
| Turn-On Delay Time | t _{d(on)} | | V _{DD} = 125 V, I _D = 4.4 A, R _G = 18 Ω, R _D = 28 Ω, see fig. 10 ^{b, c} | | 7.0 | - | - ns |
| Rise Time | t _r | | | | 13 | - | |
| Turn-Off Delay Time | t _{d(off)} | | | | 20 | - | |
| Fall Time | t _f | | | - | 12 | - | |
| Internal Drain Inductance | L _D | 6 mm (0.25") | Between lead, 6 mm (0.25") from | | 4.5 | - | |
| Internal Source Inductance | L _S | backage and center of | | - | 7.5 | - | nH |
| Drain-Source Body Diode Characteristic | s | | | | • | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 3.8 | Α |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 15 | |
| Body Diode Voltage | V_{SD} | $T_J = 25 \ ^{\circ}C, \ I_S = 3.8 \ A, \ V_{GS} = 0 \ V^b$ | | - | - | 1.8 | V |
| Body Diode Reverse Recovery Time | t _{rr} | $T_J = 25 \text{ °C}, I_F = 4.4 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$ | | - | 200 | 400 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 0.93 | 1.9 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic tu | ırn-on time is negligible (turn | -on is dor | ninated b | y L _S and | L _D) |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

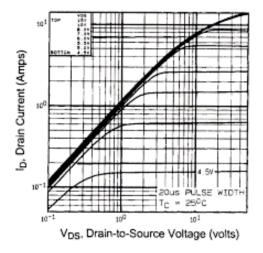


Fig. 1 - Typical Output Characteristics, $T_C = 25 \ ^{\circ}C$

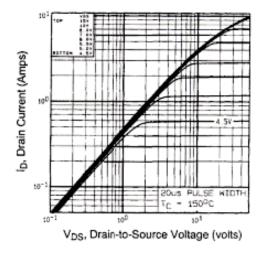


Fig. 2 - Typical Output Characteristics, T_C = 150 $^\circ C$

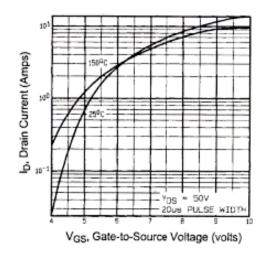


Fig. 3 - Typical Transfer Characteristics

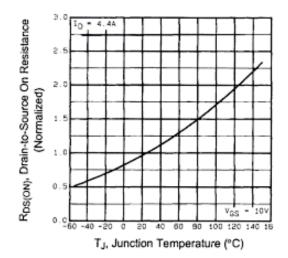


Fig. 4 - Normalized On-Resistance vs. Temperature



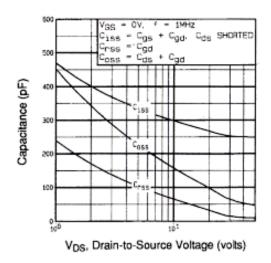
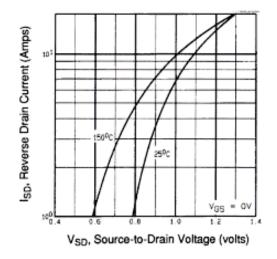


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





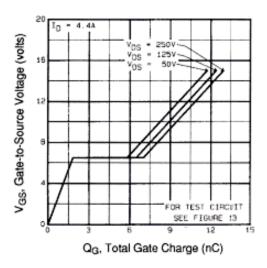


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

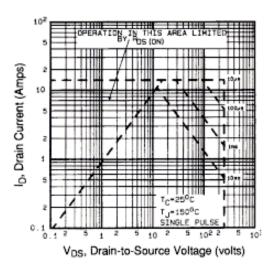


Fig. 8 - Maximum Safe Operating Area



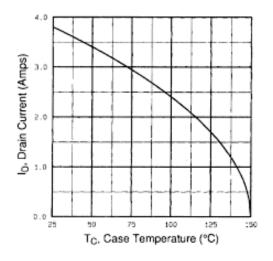


Fig. 9 - Maximum Drain Current vs. Case Temperature

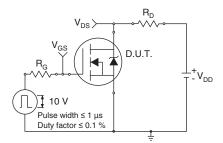


Fig. 10a - Switching Time Test Circuit

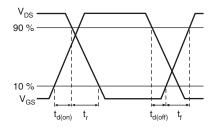


Fig. 10b - Switching Time Waveforms

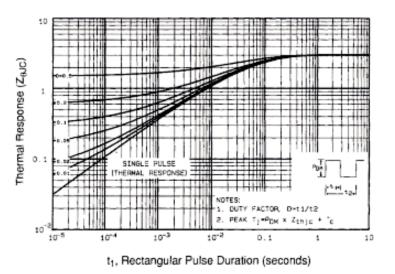


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



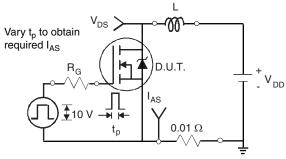


Fig. 12a - Unclamped Inductive Test Circuit

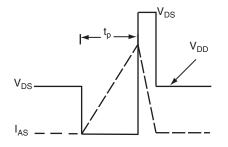


Fig. 12b - Unclamped Inductive Waveforms

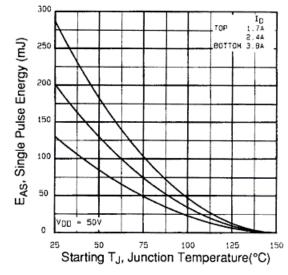


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

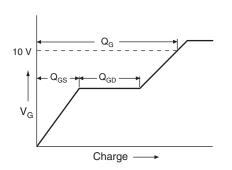


Fig. 13a - Basic Gate Charge Waveform

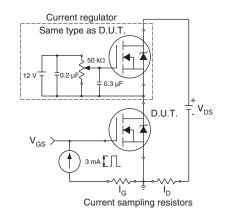


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

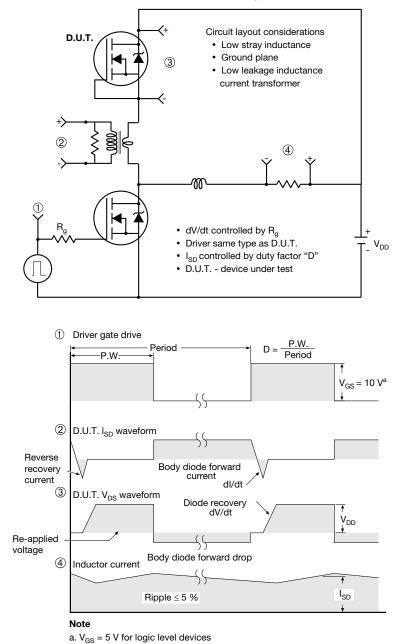
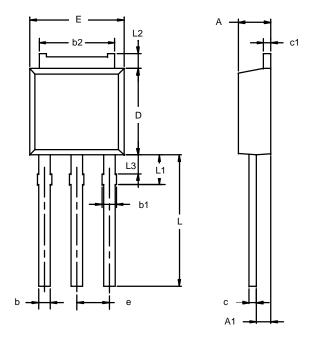


Fig. 14 - For N-Channel



TO-251AA



| | MILLIMETERS | | INC | HES |
|-----|-------------|------|-------|-------|
| Dim | Min | Max | Min | Max |
| Α | 2.21 | 2.38 | 0.087 | 0.094 |
| A1 | 0.89 | 1.14 | 0.035 | 0.045 |
| b | 0.71 | 0.89 | 0.028 | 0.035 |
| b1 | 0.76 | 1.14 | 0.030 | 0.045 |
| b2 | 5.23 | 5.43 | 0.206 | 0.214 |
| С | 0.46 | 0.58 | 0.018 | 0.023 |
| c1 | 0.46 | 0.58 | 0.018 | 0.023 |
| D | 5.97 | 6.22 | 0.235 | 0.245 |
| Е | 6.48 | 6.73 | 0.255 | 0.265 |
| е | 2.28 BSC | | 0.090 | BSC |
| L | 3.89 | 9.53 | 0.153 | 0.375 |
| L1 | 1.91 | 2.28 | 0.075 | 0.090 |
| L2 | 0.89 | 1.27 | 0.035 | 0.050 |
| L3 | 1.15 | 1.52 | 0.045 | 0.060 |

Note: Dimension L3 is for reference only.



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